Notice	of References	Cited
--------	---------------	-------

Ī	Application/Control No.	ication/Control No. Applicant(s)/Patent Under	
	10/773,287	Reexamination PALIN ET AL.	
	Examiner	Art Unit	
	WEN W. HUANG	2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0167931	11-2002	Jang et al.	455/507
*	В	US-2003/0206561	11-2003	Schmidl et al.	370/522
*	O	US-7,110,472	09-2006	Sakoda et al.	375/316
*	D	US-2003/0078006	04-2003	Mahany, Ronald L.	455/63
	Е	US-			
	F	US-			
	G	US-		-	-
	н	US-		-	
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.